

## Features

- Operating voltage: 2.2V~5.5V
- Low power consumption
  Operating: 5mA max.
- Standby: 10µA max.
- User selectable internal organization
  2K(HT93LC56): 256×8 or 128×16
- 3-wire Serial Interface
- Write cycle time: 5ms max.

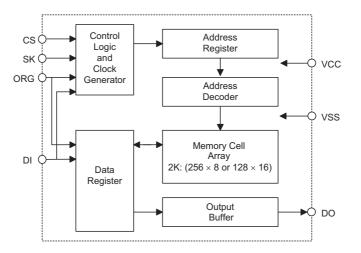
- Automatic erase-before-write operation
- Word/chip erase and write operation
- Write operation with built-in timer
- Software controlled write protection
- 10-year data retention after 100K rewrite cycles
- 10<sup>6</sup> rewrite cycles per word
- Commercial temperature range (0°C to +70°C)
- 8-pin DIP/SOP/TSSOP package

## **General Description**

The HT93LC56 is a 2K-bit low voltage nonvolatile, serial electrically erasable programmable read only memory device using the CMOS floating gate process. Its 2048 bits of memory are organized into 128 words of 16 bits each when the ORG pin is connected to VCC or organized into 256 words of 8 bits each when it is tied to

VSS. The device is optimized for use in many industrial and commercial applications where low power and low voltage operation are essential. By popular microcontroller, the versatile serial interface including chip select (CS), serial clock (SK), data input (DI) and data output (DO) can be easily controlled.

## **Block Diagram**



## **Pin Assignment**





## **Pin Description**

Pin Name	I/O	Description
CS	Ι	Chip select input
SK	Ι	Serial clock input
DI	Ι	Serial data input
DO	0	Serial data output
VSS		Negative power supply, ground
ORG	I	Internal Organization When ORG is connected to VDD or ORG is floated, the (×16) memory organization is se- lected. When ORG is tied to VSS, the (×8) memory organization is selected. There is an in- ternal pull-up resistor on the ORG pin. (HT93LC56-A)
NC		No connection
VCC		Positive power supply

# Absolute Maximum Ratings

Operation Temperature (Commercial)	0°C to 70°C
Applied $V_{CC}$ Voltage with Respect to VSS	V <sub>SS</sub> –0.3V to V <sub>SS</sub> +6.0V
Applied Voltage on any Pin with Respect to VSS	$_{\rm W}$ V <sub>SS</sub> –0.3V to V <sub>CC</sub> +0.3V

Note: These are stress ratings only. Stresses exceeding the range specified under "Absolute Maximum Ratings" may cause substantial damage to the device. Functional operation of this device at other conditions beyond those listed in the specification is not implied and prolonged exposure to extreme conditions may affect device reliability.

Sumbal	Parameter	Test Conditions		Min.	<b>T</b>	Max.	Unit
Symbol	Parameter	Vcc	Conditions	wiin.	Тур.	Wax.	Unit
V <sub>CC</sub>	Operating Voltage	_		2.2		5.5	V
I <sub>CC1</sub>	Operating Current (TTL)	5V	DO unload, SK=1MHz	_		5	mA
	Operating Current	5V	DO unload, SK=1MHz	_		5	mA
I <sub>CC2</sub>	(CMOS)	2.2V~5.5V	DO unload, SK=250kHz			5	mA
I <sub>STB</sub>	Standby Current (CMOS)	5V	CS=SK=DI=0V	_		10	μA
ILI	Input Leakage Current	5V	V <sub>IN</sub> =V <sub>SS</sub> ~V <sub>CC</sub>	0		1	μA
I <sub>LO</sub>	Output Leakage Current	5V	V <sub>OUT</sub> =V <sub>SS</sub> ~V <sub>CC</sub> , CS=0V	0		1	μA
		5V		0		0.8	V
VIL	V <sub>IL</sub> Input Low Voltage	2.2V~5.5V		0		0.1V <sub>CC</sub>	V
		5V		2		V <sub>CC</sub>	V
VIH	Input High Voltage	2.2V~5.5V		0.9V <sub>CC</sub>		V <sub>CC</sub>	V
		5V	I <sub>OL</sub> =2.1mA	_		0.4	V
V <sub>OL</sub>	Output Low Voltage	2.2V~5.5V	I <sub>OL</sub> =10μA	_		0.2	V
		5V	Ι <sub>ΟΗ</sub> =–400μΑ	2.4		_	V
V <sub>OH</sub> Output High Voltage		2.2V~5.5V	Ι <sub>ΟΗ</sub> =–10μΑ	V <sub>CC</sub> -0.2			V
CIN	Input Capacitance	_	V <sub>IN</sub> =0V, f=250kHz	_		5	pF
COUT	Output Capacitance	_	V <sub>OUT</sub> =0V, f=250kHz	_		5	pF

## **D.C. Characteristics**



# A.C. Characteristics

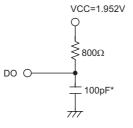
Symbol	Parameter	VCC=5	V±10%	VCC=3V±10%		VCC=2.2V		Unit
Symbol	Farameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
f <sub>SK</sub>	Clock Frequency	0	2000	0	500	0	250	kHz
t <sub>SKH</sub>	SK High Time	250	_	1000		2000		ns
t <sub>SKL</sub>	SK Low Time	250	_	1000		2000		ns
t <sub>CSS</sub>	CS Setup Time	50	_	200		200		ns
t <sub>CSH</sub>	CS Hold Time	0		0		0		ns
t <sub>CDS</sub>	CS Deselect Time	250		250		1000		ns
t <sub>DIS</sub>	DI Setup Time	100		200		400		ns
t <sub>DIH</sub>	DI Hold Time	100	_	200		400		ns
t <sub>PD1</sub>	DO Delay to "1"		250		1000		2000	ns
t <sub>PD0</sub>	DO Delay to "0"		250		1000		2000	ns
t <sub>SV</sub>	Status Valid Time		250		250		_	ns
t <sub>HV</sub>	DO Disable Time	100		400	_	400		ns
t <sub>PR</sub>	Write Cycle Time		5		5			ms

## A.C. Test Conditions

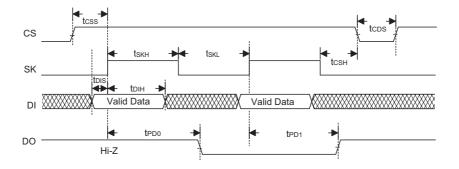
Input rise and fall time: 5ns (1V to 2V)

Input and output timing reference levels: 1.5V

Output load circuit: See Figure below.









## **Functional Description**

The HT93LC56 is accessed via a three-wire serial communication interface. The device is arranged into 128 words by 16 bits or 256 words by 8 bits depending whether the ORG pin is connected to VCC or VSS. The HT93LC56 contains seven instructions: READ, ERASE, WRITE, EWEN, EWDS, ERAL and WRAL. When the user selectable internal organization is arranged into 128×16 (256×8), these instructions are all made up of 11(12) bits data: 1 start bit, 2 op code bits and 8(9) address bits.

By using the control signal CS, SK and data input signal DI, these instructions can be given to the HT93LC56. These serial instruction data presented at the DI input will be written into the device at the rising edge of SK. During the READ cycle, DO pin acts as the data output and during the WRITE or ERASE cycle, DO pin indicates the BUSY/READY status. When the DO pin is active for read data or as a BUSY/READY indicator the CS pin must be high; otherwise DO pin will be in a high-impedance state. For successful instructions, CS must be low once after the instruction is sent. After power on, the device is by default in the EWDS state. And, an EWEN instruction must be performed before any ERASE or WRITE instruction can be executed. The following are the functional descriptions and timing diagrams of all seven instructions.

#### READ

The READ instruction will stream out data at a specified address on the DO pin. The data on DO pin changes during the low-to-high edge of SK signal. The 8 bits or 16 bits data stream is preceded by a logical "0" dummy bit. Irrespective of the condition of the EWEN or EWDS instruction, the READ command is always valid and independent of these two instructions. After the data word has been read the internal address will be automatically incremented by 1 allowing the next consecutive data word to be read out without entering further address data. The address will wrap around with CS High until CS returns to LOW.

## EWEN/EWDS

The EWEN/EWDS instruction will enable or disable the programming capabilities. At both the power on and power off state the device automatically entered the disable mode. Before a WRITE, ERASE, WRAL or ERAL instruction is given, the programming enable instruction EWEN must be issued, otherwise the ERASE/WRITE instruction is invalid. After the EWEN instruction is issued, the programming enable condition remains until power is turned off or an EWDS instruction is given. No data can be written into the device in the programming disabled state. By so doing, the internal memory data can be protected.

#### ERASE

The ERASE instruction erases data at the specified addresses in the programming enable mode. After the ERASE op-code and the specified address have been issued, the data erase is activated by the falling edge of CS. Since the internal auto-timing generator provides all timing signals for the internal erase, so the SK clock is not required. During the internal erase, we can verify the busy/ready status if CS is high. The DO pin will remain low but when the operation is over, the DO pin will return to high and further instructions can be executed.

#### WRITE

The WRITE instruction writes data into the device at the specified addresses in the programming enable mode. After the WRITE op-code and the specified address and data have been issued, the data writing is activated by the falling edge of CS. Since the internal auto-timing generator provides all timing signal for the internal writing, so the SK clock is not required. The auto-timing write cycle includes an automatic erase-before-write capability. So, it is not necessary to erase data before the WRITE instruction. During the internal writing, we can verify the busy/ready status if CS is high. The DO pin will remain low but when the operation is over, the DO pin will return to high and further instructions can be executed.

#### ERAL

The ERAL instruction erases the entire 128×16 or 256×8 memory cells to logical "1" state in the programming enable mode. After the erase-all instruction set has been issued, the data erase feature is activated by the falling edge of CS. Since the internal auto-timing generator provides all timing signal for the erase-all operation, so the SK clock is not required. During the internal erase-all operation, we can verify the busy/ready status if CS is high. The DO pin will remain low but when the operation is over, the DO pin will return to high and further instruction can be executed.

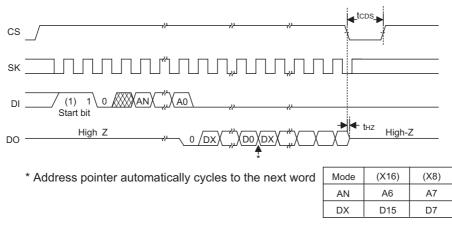
### WRAL

The WRAL instruction writes data into the entire 128×16 or 256×8 memory cells in the programming enable mode. After the write-all instruction set has been issued, the data writing is activated by the falling edge of CS. Since the internal auto-timing generator provides all timing signals for the write-all operation, so the SK clock is not required. During the internal write-all operation, we can verify the busy/ready status if CS is high. The DO pin will remain low but when the operation is over the DO pin will return to high and further instruction can be executed.

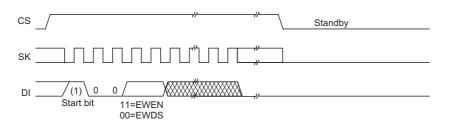


**Timing Diagrams** 

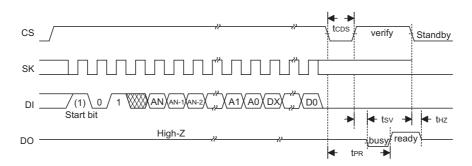
READ



## EWEN/EWDS

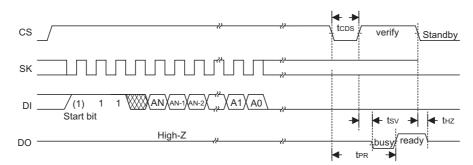


WRITE

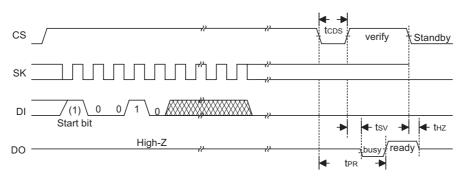




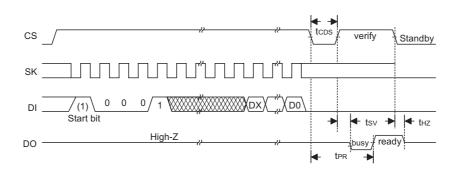
ERASE



ERAL



WRAL



# **Instruction Set Summary**

		Start	0.5	Address		Data	
Instruction	Comments	bit	Op Code	ORG=0 X8	ORG=1 X16	ORG=0 X8	ORG=1 X16
READ	Read data	1	10	XA7~A0	XA6~A0	D7~D0	D15~D0
ERASE	Erase data	1	11	XA7~A0	XA6~A0	_	_
WRITE	Write data	1	01	XA7~A0	XA6~A0	D7~D0	D15~D0
EWEN	Erase/Write Enable	1	00	11XXXXXXX	11XXXXXX	—	
EWDS	Erase/Write Disable	1	00	00XXXXXXX	00XXXXXX	_	_
ERAL	Erase All	1	00	10XXXXXXX	10XXXXXX		_
WRAL	Write All	1	00	01XXXXXXX	01XXXXXX	D7~D0	D15~D0

Note: "X" stands for "don't care"



# Package Information

8-pin DIP (300mil) Outline Dimensions



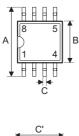




Symbol	Dimensions in mil				
Symbol	Min.	Nom.	Max.		
А	355	—	375		
В	240	_	260		
С	125		135		
D	125	_	145		
E	16		20		
F	50	_	70		
G	_	100	_		
Н	295		315		
I	335	_	375		
α	0°		15°		



## 8-pin SOP (150mil) Outline Dimensions



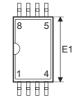


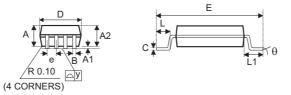


Symbol		Dimensions in mil				
Symbol	Min.	Nom.	Max.			
А	228		244			
В	149	_	157			
С	14	_	20			
C′	189		197			
D	53	_	69			
E	_	50	_			
F	4		10			
G	22		28			
Н	4		12			
α	0°		10°			



## 8-pin TSSOP Outline Dimensions



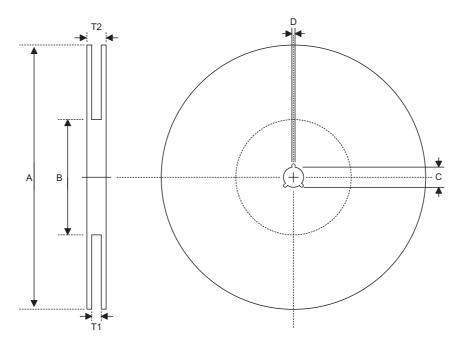


Compleal		Dimensions in mm	
Symbol	Min.	Nom.	Max.
A	1.05		1.20
A1	0.05	_	0.15
A2	0.95		1.05
В	_	0.25	_
С	0.11		0.15
D	2.90	_	3.10
E	6.20	_	6.60
E1	4.30		4.50
е	_	0.65	_
L	0.50		0.70
L1	0.90	_	1.10
у			0.10
θ	0°	—	8°



# Product Tape and Reel Specifications

# **Reel Dimensions**

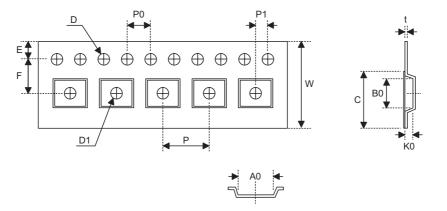


SOP 8N, TSSOP 8L

Symbol	Description	Dimensions in mm
А	Reel Outer Diameter	330±1.0
В	Reel Inner Diameter	62±1.5
С	Spindle Hole Diameter	13.0+0.5 _0.2
D	Key Slit Width	2.0±0.5
T1	Space Between Flange	12.8+0.3 _0.2
T2	Reel Thickness	18.2±0.2



## **Carrier Tape Dimensions**



# SOP 8N

Symbol	Description	Dimensions in mm
W	Carrier Tape Width	12.0+0.3 _0.1
Р	Cavity Pitch	8.0±0.1
E	Perforation Position	1.75±0.1
F	Cavity to Perforation (Width Direction)	5.5±0.1
D	Perforation Diameter	1.55±0.1
D1	Cavity Hole Diameter	1.5+0.25
P0	Perforation Pitch	4.0±0.1
P1	Cavity to Perforation (Length Direction)	2.0±0.1
A0	Cavity Length	6.4±0.1
B0	Cavity Width	5.2±0.1
K0	Cavity Depth	2.1±0.1
t	Carrier Tape Thickness	0.3±0.05
С	Cover Tape Width	9.3

## TSSOP 8L

Symbol	Description	Dimensions in mm
W	Carrier Tape Width	12.0+0.3 0.1
Р	Cavity Pitch	8.0±0.1
Е	Perforation Position	1.75±0.1
F	Cavity to Perforation (Width Direction)	5.5±0.5
D	Perforation Diameter	1.5+0.1
D1	Cavity Hole Diameter	1.5+0.1
P0	Perforation Pitch	4.0±0.1
P1	Cavity to Perforation (Length Direction)	2.0±0.1
A0	Cavity Length	7.0±0.1
B0	Cavity Width	3.6±0.1
K0	Cavity Depth	1.6±0.1
t	Carrier Tape Thickness	0.3±0.013
С	Cover Tape Width	9.3



Holtek Semiconductor Inc. (Headquarters)

No.3, Creation Rd. II, Science Park, Hsinchu, Taiwan Tel: 886-3-563-1999 Fax: 886-3-563-1189 http://www.holtek.com.tw

#### Holtek Semiconductor Inc. (Taipei Sales Office)

4F-2, No. 3-2, YuanQu St., Nankang Software Park, Taipei 115, Taiwan Tel: 886-2-2655-7070 Fax: 886-2-2655-7373 Fax: 886-2-2655-7383 (International sales hotline)

#### Holtek Semiconductor Inc. (Shanghai Sales Office) 7th Floor, Building 2, No.889, Yi Shan Rd., Shanghai, China 200233

Tel: 021-6485-5560 Fax: 021-6485-0313 http://www.holtek.com.cn

#### Holtek Semiconductor Inc. (Shenzhen Sales Office)

43F, SEG Plaza, Shen Nan Zhong Road, Shenzhen, China 518031 Tel: 0755-8346-5589 Fax: 0755-8346-5590 ISDN: 0755-8346-5591

#### Holtek Semiconductor Inc. (Beijing Sales Office)

Suite 1721, Jinyu Tower, A129 West Xuan Wu Men Street, Xicheng District, Beijing, China 100031 Tel: 010-6641-0030, 6641-7751, 6641-7752 Fax: 010-6641-0125

Holmate Semiconductor, Inc. (North America Sales Office) 46712 Fremont Blvd., Fremont, CA 94538 Tel: 510-252-9880 Fax: 510-252-9885 http://www.holmate.com

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